

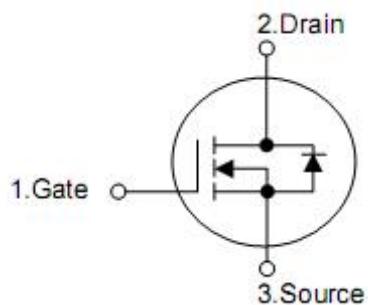
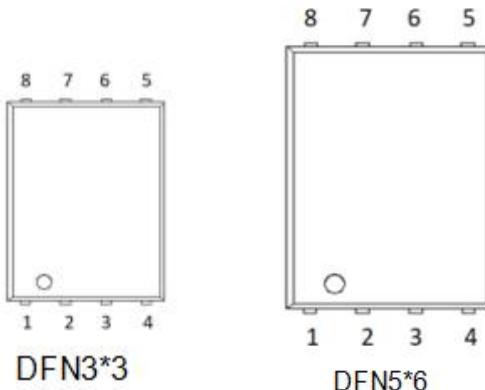
1. Description

This Power MOSFET is produced using KIA's advanced planar stripe DMOS technology. This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficiency switched mode power supplies, active power factor correction based on half bridge topology.

2. Features

- $R_{DS(on)}=3.1\text{m}\Omega$ @ $V_{GS}=10\text{V}$
- Improved dv/dt capability
- Fast switching
- Green device available

3. Symbol



Pin	Function
4	Gate
5,6,7,8	Drain
1,2,3	Source

4. Ordering information

Part Number	Package	Brand
KNG3303A	DFN3*3	KIA
KNY3303A	DFN5*6	KIA

5. Absolute maximum ratings

($T_A=25^\circ\text{C}$, unless otherwise noted)

Parameter	Symbol	Rating		Units
		DFN3*3	DFN5*6	
Drain-source voltage	V_{DSS}	30		V
Gate-source voltage	V_{GSS}	± 20		V
Continuous drain current	I_D	90*		A
		57*		A
Pulse drain current (note 1)	I_{DP}	360*		A
Avalanche current (note 2)	I_{AS}	50		A
Avalanche energy, (note 2)	E_{AS}	125		mJ
Maximum power dissipation	P_D	43.4	69	W
		0.35	0.55	W/ $^\circ\text{C}$
Junction & storage temperature range	T_J, T_{STG}	-55-150		$^\circ\text{C}$

*Drain current limited by maximum junction temperature.

6. Thermal characteristics

Parameter	Symbol	Rating		Unit
		DFN3*3	DFN5*6	
Thermal resistance, Junction-ambient	$R_{\theta JA}$	95	62	$^\circ\text{C/W}$
Thermal resistance, Junction-case	$R_{\theta JC}$	2.88	1.81	$^\circ\text{C/W}$

7. Electrical characteristics

($T_A=25^\circ\text{C}$,unless otherwise noted)

Parameter	Symbol	Test Conditions	Min	Typ	Max	Units
Drain-source breakdown voltage	BV_{DSS}	$V_{\text{GS}}=0\text{V}, I_{\text{DS}}=250\mu\text{A}$	30	-	-	V
BV_{DSS} temperature coefficient	$\Delta \text{BV}_{\text{DSS}} / \Delta T_J$	Reference to 25°C , $I_D=1\text{mA}$	-	0.03	-	$^\circ\text{C}$
Zero gate voltage drain current	I_{DSS}	$V_{\text{DS}}=30\text{V}, V_{\text{GS}}=0\text{V}, T_J=25^\circ\text{C}$	-	-	1	μA
		$V_{\text{DS}}=24\text{V}, V_{\text{GS}}=0\text{V}, T_J=125^\circ\text{C}$	-	-	10	
Gate threshold voltage	$V_{\text{GS}(\text{th})}$	$V_{\text{DS}}=V_{\text{GS}}, I_D=250\mu\text{A}$	1.2	1.6	2.5	V
$V_{\text{GS}(\text{th})}$ temperature coefficient	$\Delta V_{\text{GS}(\text{th})}$	$V_{\text{DS}}=V_{\text{GS}}, I_D=250\mu\text{A}$	-	-5	-	$\text{mV}/^\circ\text{C}$
Gate leakage current	I_{GSS}	$V_{\text{GS}}=\pm 20\text{V}, V_{\text{DS}}=0\text{V}$	-	-	± 100	nA
Drain-source on-resistance(note3)	$R_{\text{DS}(\text{on})}$	$V_{\text{GS}}=10\text{V}, I_D=24\text{A}$	-	3.1	4	$\text{m}\Omega$
		$V_{\text{GS}}=4.5\text{V}, I_D=12\text{A}$	-	4.5	6	
Forward transconductance	g_{fs}	$V_{\text{DS}}=10\text{V}, I_D=10\text{A}$	-	15.5	-	S
Gate resistance	R_g	$V_{\text{DS}}=0\text{V}, V_{\text{GS}}=0\text{V}, f=1\text{MHz}$	-	2	4	Ω
Input capacitance	C_{iss}	$V_{\text{DS}}=15\text{V}, V_{\text{GS}}=0\text{V}, f=1\text{MHz}$	-	3070		pF
Output capacitance	C_{oss}		-	400		
Reverse transfer capacitance	C_{rss}		-	315		
Turn-on delay time(note 3,4)	$t_{\text{d}(\text{on})}$	$V_{\text{DD}}=15\text{V}, I_D=15\text{A}, R_G=3.3\Omega, V_{\text{GS}}=10\text{V}$	-	12.6		nS
Rise time(note 3,4)	t_r		-	19.5		
Turn-off delay time(note 3,4)	$t_{\text{d}(\text{off})}$		-	42.8		
Fall time(note 3,4)	t_f		-	13.2		
Total gate charge(note 3,4)	Q_g	$V_{\text{DS}}=15\text{V}, V_{\text{GS}}=4.5\text{V}, I_{\text{DS}}=24\text{A}$	-	24		nC
Gate-source charge(note 3,4)	Q_{gs}		-	4.2		
Gate-drain charge(note 3,4)	Q_{gd}		-	13		
Single pulse avalanche energy	E_{AS}	$V_{\text{DD}}=25\text{V}, L=0.1\text{mH}, I_{\text{AS}}=24\text{A}$	31	-	-	mJ
Continuous source current	I_s	$V_{\text{GS}}=V_{\text{DS}}=0\text{V}, \text{force current}$	-	-	90	A
Pulsed source current (note 3)	I_{SM}		-	-	360	A
Diode forward voltage(note 3)	V_{SD}	$V_{\text{GS}}=0\text{V}, I_s=1\text{A}, T_J=25^\circ\text{C}$	-	-	1	V
Reverse recovery time	t_{rr}	$V_{\text{DS}}=30\text{V}, I_s=1\text{A}, \text{di/dt}=100\text{A}/\mu\text{s}$	-	-	-	nS
Reverse recovery charge	Q_{rr}		-	-	-	nC

Note:1: Repetitive rating, pulse width limited by max junction temperature.

2: $V_{\text{DD}}=25\text{V}, V_{\text{GS}}=10\text{V}, L=0.1\text{mH}, I_{\text{AS}}=50\text{A}, R_g=25\Omega$, starting $T_J=25^\circ\text{C}$

3: The data tested by pulsed, pulse width $\leq 300\text{us}$, duty cycle $\leq 2\%$

4: Essentially independent of operating temperature.

8. Test circuits and waveforms

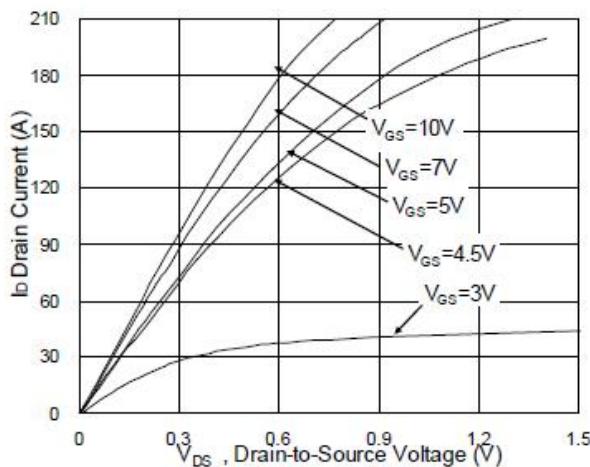


Fig.1 Typical Output Characteristics

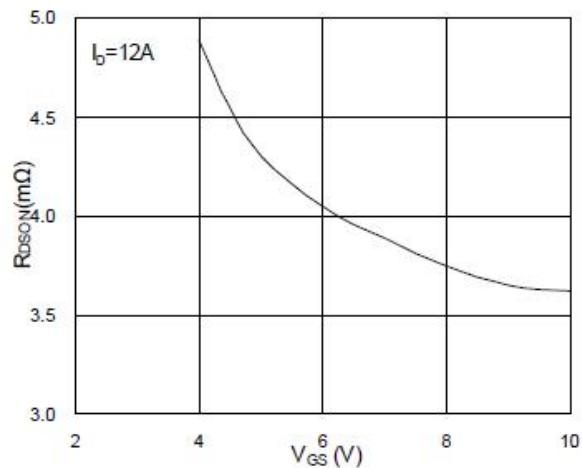


Fig.2 On-Resistance vs. G-S Voltage

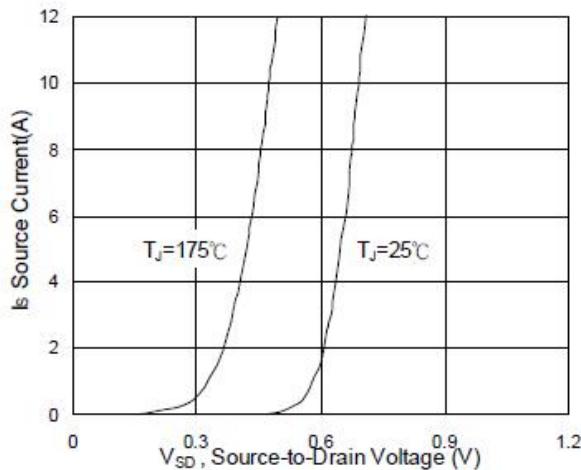


Fig.3 Forward Characteristics of Reverse

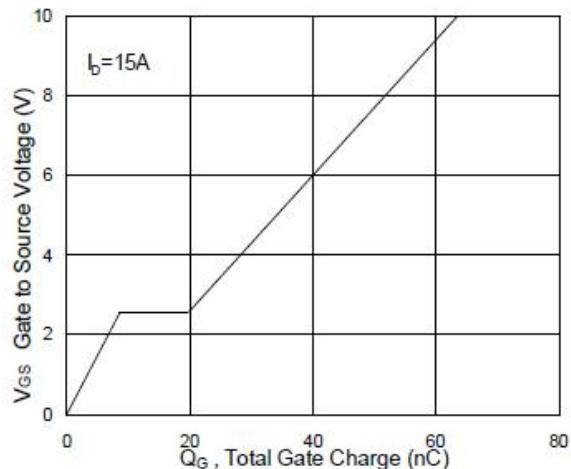


Fig.4 Gate-charge Characteristics

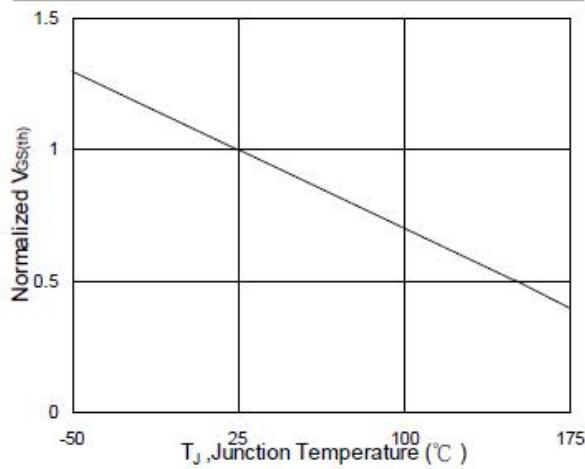


Fig.5 Normalized $V_{GS(th)}$ vs. T_J

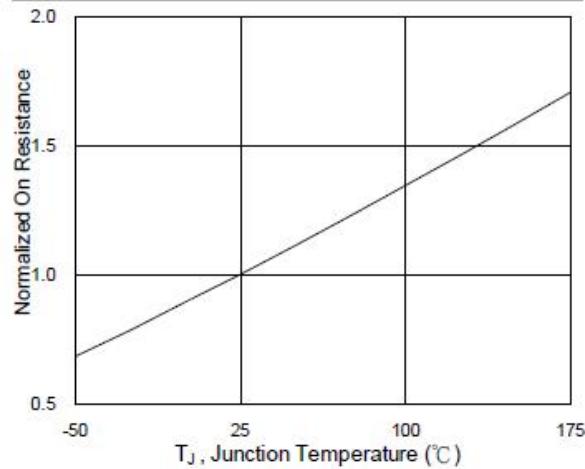


Fig.6 Normalized $R_{DS(on)}$ vs. T_J

